

Notice of References Cited

Application/Control No.

10/784,782

Applicant(s)/Patent Under
Reexamination
HAN ET AL.

Examiner

STEPHEN G. SHERMAN

Art Unit

2629

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0020674	01-2003	Higashino et al.	345/60
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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